


PATENT NUMBER

U.S. **UTILITY** Patent Application

<p>  O.I.P.E. SCANNED <u>AA</u> Q.A. <u>65</u>² </p>	<p>PATENT DATE</p>
--	---------------------------

APPLICATION NO. 09/626106	CONT/PRIOR F	CLASS 250	SUBCLASS 306	ART UNIT 2881	EXAMINER SOUW
------------------------------	-----------------	--------------	-----------------	------------------	------------------

APPLICANTS

Этюд

Takafumi Morimoto
Hiroshi Kuroda

Scanning probe microscope and method of measurement

PTO-2040
12/99

ISSUING CLASSIFICATION

ISSUING CLASSIFICATION												
ORIGINAL					CROSS REFERENCE(S)							
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
INTERNATIONAL CLASSIFICATION												

☐ Continued on Issue Slip Inside File Jacket

<input type="checkbox"/> TERMINAL DISCLAIMER	DRAWINGS			CLAIMS ALLOWED	
	Sheets Drwg.	Figs. Drwg.	Print Fig.	Total Claims	Print Claim for O.G.
<input type="checkbox"/> The term of this patent subsequent to _____ (date) has been disclaimed.	_____ (Assistant Examiner) _____ (Date)			NOTICE OF ALLOWANCE MAILED	
<input type="checkbox"/> The term of this patent shall not extend beyond the expiration date of U.S Patent. No. _____ _____ _____				ISSUE FEE	
	Amount Due Date Paid				
<input type="checkbox"/> The terminal ____ months of this patent have been disclaimed.	_____ (Legal Instruments Examiner) _____ (Date)			ISSUE BATCH NUMBER	
WARNING: The information disclosed herein may be restricted. Unauthorized disclosure may be prohibited by the United States Code Title 35, Sections 122, 181 and 368. Possession outside the U.S. Patent & Trademark Office is restricted to authorized employees and contractors only.					